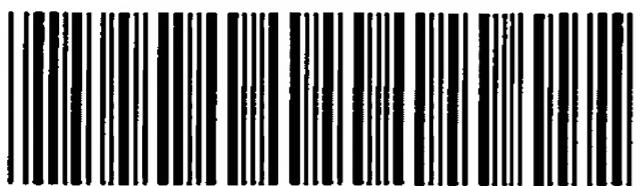


Search Notes

Application/Control No.

10/665,654

Examiner

Linh M. Nguyen

Applicant(s)/Patent under
Reexamination

CHEN ET AL.

Art Unit

2816

SEARCHED

Class	Subclass	Date	Examiner
327	261	10/14/85	LMN
4	263	6	6
4	264	4	4
4	268	4	4
4	288	4	4
4	290	4	4

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner